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Power System Protection and Fault Location Technologies in Smart Grid Systems

Guest Editors:

Dr. Shuiging Xu

Prof. Dr. Darong Huang

Prof. Dr. Ke Zhang

Dr. Zheren Zhu

Deadline for manuscript submissions:

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Message from the Guest Editors

Dear Colleagues,

In the past few decades, the global demand for power systems has been growing steadily. In terms of practical applications, how to ensure the efficient and stable operation of power systems has always been a key problem in power system development.

This Special Issue intends to collect advanced and updated designs of fault diagnosis methods for power systems from both academia and industry. Topics of interest to this Special Issue include but are not limited to:

- Performance evaluation and optimization of power systems and electrical equipment;
- Online monitoring and fault diagnosis for power systems and electrical equipment;
- Fault-tolerant control and performance recovery of power systems and electrical equipment;
- Lifecycle management and remaining useful life prediction of electrical equipment;
- Fault identification and prognosis for power systems and electrical equipment;
- Fault simulation and injection for power systems.











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Editor-in-Chief

Prof. Dr. Flavio Canavero

Department of Electronics and Telecommunications, Politecnico di Torino, 10129 Torino, Italy

Message from the Editor-in-Chief

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